

Search Notes

Application/Control No.

10/526,797

Examiner

Christopher P. Schwartz

Applicant(s)/Patent under
Reexamination

CHUNG, EUI HYUP

Art Unit

3683

SEARCHED

Class	Subclass	Date	Examiner
188	300	3/27/2007	CPS
267	64.12		
	120		
297	344.19		
	463.1		
248	161		
	406.2		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	3/27/2007	